

# **Cycle 30 STIS Regular Calibration Program**

STIS Team

2022June01

# STIS Calibration and Monitor Orbits

## Approved by Cycle

	# of Programs	External Orbits	Parallel Orbits	Internal Orbits	Total Orbits
<b>Cycle 17</b>	25	68	0	1816	1884
<b>Cycle 18</b>	20	22	0	1370	1392
<b>Cycle 19</b>	18	21	0	1418	1439
<b>Cycle 20</b>	20	21	0	1391	1412
<b>Cycle 21</b>	20	21	0	1392	1413
<b>Cycle 22</b>	19	21	0	1387	1408
<b>Cycle 23</b>	22	31	1	1380	1416
<b>Cycle 24</b>	21	27	1	1355	1386
<b>Cycle 25</b>	21	26	0	1355	1381
<b>Cycle 26</b>	21	27	1	1355	1383
<b>Cycle 27</b>	20	33	0	1358	1391
<b>Cycle 28</b>	23	52	[8]	1349	1401
<b>Cycle 29</b>	19	21	[8]	1369	1390
<b>Cycle 30*</b>	20	26	[8]	1342	1368

[ ] denotes coordinated parallel orbits included with the corresponding external orbits

\* Regular calibration and monitoring programs requested for cycle 30

# STIS Cycle 29 Calibration and Monitoring Orbits Approved

Prop. ID	Title	External	External Parallel	Internal	Frequency (orbits x repeats)	Cycle 28 Allocation
<b>CCD Monitors</b>						
I6543	STIS CCD Performance Monitor			14	7x2	14
I6544-I6546	STIS CCD Dark Monitor			742	1x252 + 1x252 + 1x238	728
I6547-I6548	STIS CCD Bias and Read Noise Monitor			371	1x189 + 1x182	365
I6549	STIS CCD Hot Pixel Annealing			39*	3x13	39*
I6550	STIS CCD Spectroscopic Flat-Field Monitor			19	1x10 + 1x9	19
I6551	STIS CCD Imaging Flat-Field Monitor			4	1x4	4
I6552	STIS CCD Spectroscopic Dispersion Solution Monitor			3	3x1	3
I6553	STIS CCD Sparse Field CTE			50*	50x1	50*
I6555	STIS CCD Full Field Sensitivity	1			1x1	1
I6557	STIS Slit Wheel Repeatability			1*	1x1	1*
I6556	STIS CCD Spectroscopic Sensitivity Monitor	5			1x3 (L) + 2x1 (M)	5
<b>MAMA Monitors</b>						
I6558	STIS MAMA Spectroscopic Dispersion Solution Monitor			7	7x1	7
I6554	STIS MAMA Full Field Sensitivity	3			1x3	3
I6559	STIS MAMA Spectroscopic Sensitivity and Focus Monitor	12	[8]		1x3(L), 1x1(M), 2x4(E)	12
I6560	STIS FUV MAMA Dark Monitor			54	6x9	54
I6561	STIS NUV MAMA Dark Monitor			52	2x26	52
I6562	STIS MAMA NUV Flat-Field Monitor			11*	1x11	11*
I6563	STIS MAMA Fold Distribution			2	2x1	2
<b>Special and contingency programs</b>						
I6542	STIS MAMA Anomalous Recovery (Contingency)			(8)		(8)
<b>TOTAL</b>	<b>Cycle 29 orbit request</b>	<b>21</b>	<b>[8]</b>	<b>1369+ (8)</b>		<b>Ext: 52 Int: 1349+(8)</b>

\* Contains internal parallel orbits > 1800s.

Green means "executing on alternating cycle only"

( ) Indicates contingency orbits not included in Cycle 29 request.

[ ] Indicates coordinated parallel orbits included in the external total

# **Cycle 30 STIS Calibration Plan: Routine Programs & Monitoring**

# STIS Cycle 30 Calibration and Monitoring Orbits Requested

Prop. ID	Title	External	External Parallel	Internal	Frequency (orbits x repeats)	Cycle 29 Allocation
CCD Monitors						
	STIS CCD Performance Monitor			14	7x2	14
	STIS CCD Dark Monitor			728	1x248 + 1x248 + 1x246	742
	STIS CCD Bias and Read Noise Monitor			364	1x182 + 1x183	371
	STIS CCD Hot Pixel Annealing			39*	3x13	39*
	STIS CCD Spectroscopic Flat-Field Monitor			19	1x10 + 1x9	19
	STIS CCD Imaging Flat-Field Monitor			4	1x4	4
	STIS CCD Spectroscopic Dispersion Solution Monitor			3	3x1	3
	STIS CCD Sparse Field CTE			50*	50x1	50*
	STIS CCD Full Field Sensitivity	1			1x1	1
	STIS Slit Wheel Repeatability			1*	1x1	1*
	STIS CCD Spectroscopic Sensitivity Monitor	5			1x3 (L) + 2x1 (M)	5
MAMA Monitors						
	STIS MAMA Spectroscopic Dispersion Solution Monitor			7	7x1	7
	STIS MAMA Full Field Sensitivity	3			1x3	3
	STIS MAMA Spectroscopic Sensitivity and Focus Monitor	12	[8]		1x3(L), 1x1(M), 2x4(E)	12
	STIS FUV MAMA Dark Monitor			48	6x8	54
	STIS NUV MAMA Dark Monitor			52	2x26	52
	STIS MAMA FUV Flat-Field Monitor			11*	1x11	11*
	STIS MAMA Fold Distribution			2	2x1	2
Special, CCD/MAMA, and contingency programs						
	Monitoring the Three Primary White Dwarf Standard Stars	5			5x1	
	STIS MAMA Anomalous Recovery (Contingency)			(8)		(8)
TOTAL	Cycle 30 orbit request	26	[8]	1342+ (8)		Ext: 21 Int: 1369+(8)

\* Contains internal parallel orbits > 1800s.

Green means “executing on alternating cycle only”

( ) Indicates contingency orbits not included in Cycle 30 request.

[ ] Indicates coordinated parallel orbits included in the external total

# **STIS Cycle 30 Calibration Changes from Cycle 29**

Two programs alternate between even and odd cycles:

- the STIS MAMA FUV Flat-Field Monitor will execute in Cycle 30 instead of the NUV Flat-Field Monitor
- the CCD Sparse Field CTE Internal program observations will use the GAIN = 4 setting this cycle (instead of GAIN = 1)

The biennial program monitoring the three primary white dwarf flux standards was executed in cycle 28, and is now a regular program.

Parallel exposures with WFC3 are again added to the STIS MAMA Spectroscopic Sensitivity and Focus Monitor echelle visits

Cycle 30 has 52 weeks (instead of 53) – affects daily CCD monitors

# **STIS/CCD Programs**

**Note: STIS Cycle 30 Phase 1s Include  
Cycle 29 Usage Statistics**

# STIS CCD Performance Monitor

## PI: Doug Branton

<b>Purpose</b>	To measure the baseline performance of the CCD detector.
<b>Description</b>	This program monitors the performance of the CCD detector on orbit for amplifier D only. Bias and flat field exposures are taken to measure read noise, CTE (EPER test), spurious charge, and gain values with full frame observations. Bias exposures are also taken in sub-array readouts to check the bias level for ACQ and ACQ/PEAK observations. All orbits < 1800s
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time.
<b>Resources Required: Observations</b>	14 internal orbits performed in 2 groups of 7
<b>Resources Required: Analysis</b>	2 FTE weeks for analysis and documentation.
<b>Products</b>	Possible update of the gain, bias level, and read noise values in ccdtab. This also provides a relative measure of CTI via the extended pixel edge response test. Possible flight software updates of table CCDBiasSubtractionValue. Summary in the end of cycle ISR and updates to the STIS monitor webpages.
<b>Accuracy Goals</b>	Read noise good to +/- 0.3 ADU, gain error < 0.08 ADU
<b>Scheduling &amp; Special Requirements</b>	Visits occur every 6 months in Mar and Sept.
<b>Changes from Cycle 29</b>	No changes.

# STIS CCD Dark Monitor (Parts 1, 2, and 3)

## PI: Sophia Medallon

<b>Purpose</b>	Monitor dark current for the STIS CCD.
<b>Description</b>	Routine monitoring with Amp D and GAIN = 1: obtain 2 visits per day
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time
<b>Resources Required: Observations</b>	252 (part 1) + 252 (part 2) + 224 (part 3) internal orbits <1800s.
<b>Resources Required: Analysis</b>	6 FTE weeks; Retrieve and construct superdarks. These superdarks are compared to previous superdarks and the image statistics are checked to see if there are any anomalous statistical deviations. CTI analysis based on short darks is performed.
<b>Products</b>	Weekly CRDS reference files (superdarks) and a summary in the end of cycle ISR and update of the monitor webpage.
<b>Accuracy Goals</b>	Superdark rms < 0.012 e-/s and S/N > 1.0 per pixel in superdarks.
<b>Scheduling &amp; Special Requirements</b>	Two orbits each day.
<b>Changes from Cycle 29</b>	No Changes

# STIS CCD Bias and Read Noise Monitor (Parts 1 & 2)

PI: Doug Branton

<b>Purpose</b>	Monitor the bias in the 1x1 bin settings at gain=1, and 1x1 at gain = 4, to build up high S/N superbias and track the evolution of hot columns. Also GAIN=1 and GAIN=4, 1x1 biases through AMPS A and C to use in combination with biases taken through AMP D for monitoring of the read noise.
<b>Description</b>	Take full frame bias exposures in the 1x1 bin settings at GAIN = 1, and at GAIN = 4 with nominal AMP D. Take full frame biases through AMPs A and C in GAIN = 1 and 4 as well for performing read noise monitoring. All exposures are internal and fit in occultation orbits.
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time
<b>Resources Required: Observations</b>	182 (part 1) + 182 (part 2) internal orbits
<b>Resources Required: Analysis</b>	2 FTE weeks. Retrieve and construct superbias. These are compared to previous superbias and the image statistics are checked to see if there are any anomalous deviations. Biases with AMPS A and C allow for monitoring of the read noise.
<b>Products</b>	Weekly CRDS reference files (superbias) and a summary in the end of cycle ISR
<b>Accuracy Goals</b>	Superbias RMS < 0.95 e- at GAIN = 1 1x1 and RMS < 1.13 e- at GAIN = 4 1x1, S/N > 1 per pixel.
<b>Scheduling &amp; Special Requirements</b>	One orbit per day for the routine monitor. The additional biases for AMPs A and C should be taken for 6 consecutive days during most months.
<b>Changes from Cycle 29</b>	No changes

# STIS CCD Hot Pixel Annealing

## PI: Sophia Medallon

<b>Purpose</b>	To anneal hot pixels. The effectiveness of the CCD hot pixel annealing is assessed by measuring the dark current behavior before and after annealing.
<b>Description</b>	The characteristics of the CCD will first be defined by a series of bias, dark and flat-field exposures taken before the anneal. The CCD Thermoelectric cooler will be turned off to allow the CCD detector temperature to rise from $\sim -80$ C to $+5$ C. The CCD will be left in the uncooled state for approximately 12 hours. At the end of this period the Thermoelectric cooler is turned back on and the CCD is cooled to its normal operating temperature. Since the CCD on Side-2 does not have thermistor, a 4 hour period, at a minimum, is necessary to ensure that the CCD is cool and stable. After the CCD has stabilized, bias, dark and flat-field images will be repeated to check for changes in the CCD characteristics. The flat-field exposures will permit evaluation of any window contamination acquired during the annealing period. Pure parallel mode.
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time.
<b>Resources Required: Observations</b>	39 internal orbits (3 every 4 weeks) and all orbits $>1800$ s.
<b>Resources Required: Analysis</b>	2 FTE weeks. By comparing the number of hot pixels before and after the anneal, we see if the hot pixels decrease and estimate the number of hot pixels that persist after the process.
<b>Products</b>	Hot pixel growth rate, median dark count rate, and a summary in the end of cycle ISR
<b>Accuracy Goals</b>	Measure the growth rate of hot pixels to within 1% if possible
<b>Scheduling &amp; Special Requirements</b>	Pure parallel mode exposures. Anneals will execute every 4 <sup>th</sup> week using 3 orbits.
<b>Changes from Cycle 29</b>	No changes.

# STIS CCD Spectroscopic Flat-Field Monitor

## PI: Joleen Carlberg

<b>Purpose</b>	Obtain medium resolution grating flats to determine the pixel-to-pixel variation for spectroscopic observations and produce the Cycle 30 reference p-flat (M and L modes).
<b>Description</b>	We use the tungsten lamp and the G430M grating to determine the pixel-to-pixel variation of the STIS CCD in spectroscopic mode. The flat exposures are taken with the 50CCD and 52x2 apertures at 5 offset positions in order to map -- with a sufficient SNR -- the whole sensitive area of the detector. The expected cumulative signal $\geq 1.4E6$ ADU/pixels; while the expected accuracy will be $\leq 1.5\%$ . All orbits are $< 1800$ s.
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time (cycle 29).
<b>Resources Required: Observations</b>	19 internal orbits (all $< 1800$ s)
<b>Resources Required: Analysis</b>	2.5 weeks FTE
<b>Products</b>	Reference files, summary in end of cycle ISR and special ISR as applicable
<b>Accuracy Goals</b>	$\leq 1.5\%$ flat field accuracy
<b>Scheduling &amp; Special Requirements</b>	9 orbits with G430M/5612 & 50CCD spread across the cycle; 1 visit every ~40 days 10 orbits with the G430M/5612 & 52x2
<b>Changes from Cycle 29</b>	No changes.

# STIS CCD Imaging Flat-Field Monitor

## PI: Daniel Welty

<b>Purpose</b>	Purpose: Collect high SNR white light imaging flats (aperture=50CCD) for monitoring purposes and to create a new reference p-flat for coronagraphic (and imaging) observations.
<b>Description</b>	Once every 3 months, obtain a series of imaging CCD flats using the MIRROR and the unfiltered 50CCD aperture. The 3 months cadence will allow us to keep monitoring possible (but unlikely) variations across the cycle; while the combined observations will allow us to obtain an average signal $\sim 620000$ ADU/pix (similar to past cycles) and create a high accuracy ( $\sim 1\%$ ) imaging p-flat. The remaining time in each orbit/visit will be used to monitor the stability of the CORON aperture due to the MSM limited reproducibility.
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time (Cycle 29)
<b>Resources Required: Observations</b>	4 internal orbits
<b>Resources Required: Analysis</b>	4 weeks FTE
<b>Products</b>	Reference p-flat and TIR or ISR as relevant.
<b>Accuracy Goals</b>	$\sim 1\%$ flat field accuracy
<b>Scheduling &amp; Special Requirements</b>	1 orbit every 3 months.
<b>Changes from Cycle 29</b>	No changes

# STIS CCD Spectroscopic Dispersion Solution Monitor

## PI: Daniel Welty

<b>Purpose</b>	To monitor the wavelength calibration / dispersion solutions for some configurations of the STIS/CCD.
<b>Description</b>	Internal wavecalcs will be obtained with all 6 gratings (G230LB, G230MB, G430L, G430M, G750L, G750M) supported for use with the CCD, for settings chosen to cover Cycle 30 use and to overlap with those used in previous calibration programs (to continue long-term monitoring). All observations will be obtained with the 52x0.1 aperture, which maps to 2 pixels at the CCD. As in previous cycles, the HITMI lamp will be used, as it has a more favorable spatial illumination pattern, dropping by only a factor of 3 at row 900 (near the EI pseudo-aperture), relative to the peak brightness at row 420.
<b>Fraction GO/GTO Programs Supported</b>	14.9% of total STIS prime science exposure time (cycle 29)
<b>Resources Required: Observations</b>	3 internal orbits
<b>Resources Required: Analysis</b>	2 FTE weeks
<b>Products</b>	Update wavelength dispersion reference file (as needed, with ISR); summary in the end of cycle ISR
<b>Accuracy Goals</b>	0.2 pixels (wavelength accuracy for row 900) -- Wavelength coefficients are tabulated every 32 rows in the CCD dispersion (_dsp) reference file. Exposure times in this program have typically been chosen to yield a S/N ratio of at least 10 per pixel in row 900 after combining 32 rows. This constraint must be satisfied in the left, middle, and right thirds of the image. Existing recent HITMI wavecalcs were used to estimate exposure times.
<b>Scheduling &amp; Special Requirements</b>	These observations are taken once per cycle (typically Nov-Dec).
<b>Changes from Cycle 29</b>	<b>No changes</b> from Cycle 29 (the changes made for cycle 26 should yield adequate sets of measurable lines in all settings)

# STIS CCD Sparse Field CTE Internal

## PI: Sean Lockwood

<b>Purpose</b>	Re-establish an accurate correction for parallel register CTE losses that can be used for direct analysis of science data with negligible background. Do measurements for one gain setting (GAIN=4), alternating with GAIN=1 every-other-cycle.
<b>Description</b>	The sparse field CTE will be measured via internal calibration lamp observations taken through narrow slits. Using the onboard tungsten lamp, narrow slit images are projected at different positions on the detector. At each position a series of exposures is taken alternating between the 'A' and 'C' amplifiers for readout. The further the charge needs to be shifted to be read out, the more charge it will lose. For the parallel CTE measurement, the test will use the the cross disperser slits: 0.05x3INDB and 0.05x3INDA. In order to test the effects of different bias voltages and readout timing, the whole series of exposures is executed once for GAIN=4 and once for GAIN=1 every-other cycle; this process requires a total of 50 orbits per cycle which includes various sets of biases and darks.
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time (cycle 29)
<b>Resources Required: Observations</b>	50 internal visits (7/50 visits will exceed the 1800 s limit by ~100 s in order to capture the full sequence of exposures required for best analysis.)
<b>Resources Required: Analysis</b>	3 FTE weeks
<b>Products</b>	Determine slope for time dependent empirical flux correction of CTE, possible update of ccdtab reference file, and inclusion in a summary ISR.
<b>Accuracy Goals</b>	1%
<b>Scheduling &amp; Special Requirements</b>	Schedule between 2022-November-01 and 2023-February-01. Visits should execute in order.
<b>Changes from Cycle 29</b>	Data taken for gain=4 instead of gain=1 (alternates every cycle).

# STIS CCD Full-Field Sensitivity

## PI: Sean Lockwood

<b>Purpose</b>	To monitor CCD sensitivity over the whole field of view.
<b>Description</b>	Measure a photometric standard star field in Omega Cen in 50CCD annually to monitor CCD sensitivity over the whole field of view. Keep the spacecraft orientation within a suitable range (+/- 5 degrees) to keep the same stars in the same part of the CCD for every measurement. This test will give a direct transformation of the 50CCD magnitudes to the Johnson-Cousins system for red sources. These transformations should be accurate to 1%. The stability of these transformations will be measured to the sub-percent level. These observations also provide a check of the astrometric and PSF stability of the instrument over its full field of view. All external orbits > 1800s.
<b>Fraction GO/GTO Programs Supported</b>	17.8% of total STIS exposure time (cycle 28).
<b>Resources Required: Observations</b>	1 external orbit
<b>Resources Required: Analysis</b>	1 FTE week
<b>Products</b>	Summary in the end of cycle ISR
<b>Accuracy Goals</b>	1%
<b>Scheduling &amp; Special Requirements</b>	ORIENT 310.0D TO 310.0 D; BETWEEN 15-JAN-2023:00:00:00 AND 20-MAR-2023:00:00:00
<b>Changes from Cycle 29</b>	Update coordinates to compensate for cyc29 offset due to GS change

# STIS Slit Wheel Repeatability Monitor

PI: Amy M Jones

<b>Purpose</b>	To test the repeatability of the slit wheel motions
<b>Description</b>	A sequence of lamp spectra taken using grating G230MB (2697A), cycling through the three narrowest long STIS slits.
<b>Fraction GO/GTO Programs Supported</b>	92% of total STIS exposure time (Cycle 29)
<b>Resources Required: Observations</b>	One internal orbit (24 exposures, ~40 minutes total) once per cycle
<b>Resources Required: Analysis</b>	2 FTE days
<b>Products</b>	The average and maximum shifts observed in the dispersion and spatial directions. Possibly an ISR that sums up the analysis and results from the past few cycles
<b>Accuracy Goals</b>	Shifts should be smaller than 0.5 pixels
<b>Scheduling &amp; Special Requirements</b>	Between 07 Nov 2022 and 05 Nov 2023 (generally early in the cycle)
<b>Changes from Cycle 29</b>	No changes

# STIS CCD Spectroscopic Sensitivity Monitor

## PI: Svea Hernandez

<b>Purpose</b>	Monitor the spectroscopic sensitivity of the STIS CCD using both low- and medium-resolution gratings to reveal contamination issues that may affect the spectroscopic throughput.
<b>Description</b>	This program will monitor the STIS CCD spectroscopic sensitivity using a high-declination spectroscopic calibration star (AGK+81D266). The results will be compared to previous observations to detect trends. The L modes will be observed at the nominal and EI positions every four months with one orbit per visit. The M modes will be observed at the nominal and EI positions as well, once per year with two orbits per visit.
<b>Fraction GO/GTO Programs Supported</b>	17.8% of STIS total exposure time (cycle 29).
<b>Resources Required: Observations</b>	5 external orbits
<b>Resources Required: Analysis</b>	7 FTE weeks: 3 FTE weeks for sensitivity analysis, 2 weeks for ISR, 2 FTE weeks for CTE correction verification
<b>Products</b>	Updated STIS TDSTAB file, an ISR on STIS sensitivity monitoring, summary in end of cycle ISR
<b>Accuracy Goals</b>	Minimum signal to noise of 50 per resolution element at the least sensitive wavelength.
<b>Scheduling &amp; Special Requirements</b>	1 orbit every 4 months for L modes. 2 orbits/year for M modes.
<b>Changes from Cycle 29</b>	No changes

# **STIS/MAMA Programs**

# STIS MAMA Spectroscopic Dispersion Solution Monitor

## PI: Daniel Welty

<b>Purpose</b>	To monitor the wavelength calibration / dispersion solutions for selected STIS MAMA configurations.
<b>Description</b>	Internal wavecalcs will be obtained with gratings at primary and secondary central wavelengths chosen to cover Cycle 30 use and to overlap with configurations used in previous calibration programs (to continue long-term monitoring). This program uses the LINE lamp for a total of about 1.6 hours (typically at a lamp current of 10 mA) – consuming about 0.1% of the 15000 mAhour expected lifetime. The HITM2 lamp (which is brighter below 1270 Å) is now used for two of the shorter wavelength settings. Moderately deep wavecalcs are included for some echelle modes and for some first order modes to ensure detection of weak lines. All orbits < 1800s.
<b>Fraction GO/GTO Programs Supported</b>	77.1% of total STIS prime science exposure time (cycle 29)
<b>Resources Required: Observations</b>	7 internal orbits
<b>Resources Required: Analysis</b>	6 FTE weeks
<b>Products</b>	Update wavelength dispersion reference file (as needed; with ISR); summary in end of cycle ISR
<b>Accuracy Goals</b>	0.1-0.2 pixels internal wavelength precision.
<b>Scheduling &amp; Special Requirements</b>	These observations are taken once per cycle (typically in Nov-Dec). The shortest wavelength settings should avoid orbits in which the FUV glow is strong (if possible).
<b>Changes from Cycle 29</b>	<b>No changes from Cycle 29</b> (the changes made for cycle 26 should yield adequate sets of measurable lines in all settings)

# STIS MAMA Full-Field Sensitivity

## PI: Sean Lockwood

<b>Purpose</b>	To monitor the sensitivity of the FUV-MAMA and NUV-MAMA over the full field
<b>Description</b>	By observing the globular cluster NGC6681 once every year at roughly the same orientation, we will monitor the full-field sensitivity of the MAMA detectors and their astrometric and PSF stability. These observations will be used to look for contamination, throughput changes, or formation of color centers in the photocathode and window that might be missed by spectroscopic monitoring or difficult to interpret in flat-fielding. Although this test is done using MAMA imaging modes, the confirmation of detector stability and uniformity provided by this monitor is important for spectroscopic observations as well. All orbits > 1800s.
<b>Fraction GO/GTO Programs Supported</b>	82.2% of STIS total exposure time (cycle 29)
<b>Resources Required: Observations</b>	3 external orbits
<b>Resources Required: Analysis</b>	1 FTE week
<b>Products</b>	Summary in the end of cycle ISR
<b>Accuracy Goals</b>	1%
<b>Scheduling &amp; Special Requirements</b>	Should roughly match most common orient from previous observations. ORIENT 260.0D TO 266.0 D; BEFORE 16-JUN-2023:00:00:00
<b>Changes from Cycle 29</b>	No Changes

# STIS MAMA Spectroscopic Sensitivity & Focus Monitor

## PI: Svea Hernandez

<b>Purpose</b>	Monitor the sensitivity of each STIS MAMA grating mode to detect any changes due to contamination or other effects, and monitor the STIS focus in spectroscopic and imaging modes.
<b>Description</b>	<ul style="list-style-type: none"> <li>- SENSITIVITY: Obtain exposures in each of the two low-resolution MAMA spectroscopic modes every 4 months, in each of the 2 medium-resolution modes once a year, and in each of the 5 echelle modes every 3 months, using unique calibration standards for each mode (L: GRW+70D5824, M: AGK+81D266, E: BD+28D421 I), and compare the results to the first observations to detect any trends.</li> <li>- FOCUS: For this cycle we will continue to monitor the STIS focus (small aperture throughput as a function of UV wavelength) by including a direct comparison between the G230LB 0.1X0.09 and 52x2 throughput, as well as a narrow band OII CCD image during each L-Mode visit. We will continue to also include an OII image with the M-mode visit. Echelle visits include parallel WFC3/F438W observations to independently monitor the focus on orbital timescales.</li> </ul>
<b>Fraction GO/GTO Programs Supported</b>	Focus monitor: 100% of STIS exposures. Sensitivity monitor: 82.2% of STIS total exposure time (cycle 29)
<b>Resources Required: Observations</b>	12 external orbits (coordinated parallel observations included in 8 of those)
<b>Resources Required: Analysis</b>	8 FTE weeks: 3 FTE weeks for sensitivity analysis, 2 weeks for ISR, 3 for focus.
<b>Products</b>	Updated STIS TDSTAB file and ISRs on STIS sensitivity monitoring and focus monitoring. Summary in the end of cycle ISR.
<b>Accuracy Goals</b>	Minimum signal to noise of 50 per resolution element at the least sensitive wavelength. 10% for focus changes.
<b>Scheduling &amp; Special Requirements</b>	Visits need to be approximately equally spaced throughout the cycle. MAMA monthly offsets cancelled for L and M mode observations. SAA-free orbits.
<b>Changes from Cycle 29</b>	No changes

# STIS FUV MAMA Dark Monitor

## Sean Lockwood

<b>Purpose</b>	Monitor the behavior of the dark current in the FUV MAMA detector, provide data for dark count corrections for faint object observations, and also provide a check on the health of the detector
<b>Description</b>	Every six weeks a set of six exposures of 1300s is taken with the FUV MAMA with the shutter closed. The exposures are evenly spread over a six-hour SAA-free period.
<b>Fraction GO/GTO Programs Supported</b>	46.4% of STIS total exposure time (cycle 29)
<b>Resources Required: Observations</b>	48 internal orbits
<b>Resources Required: Analysis</b>	2 FTE-weeks
<b>Products</b>	Dark current images and temperature-dependent formula for applying to an individual observation. Update to monitoring webpage. DQ flags for pipeline super-darks.
<b>Accuracy Goals</b>	1% (statistical error on the total number of counts in an image)
<b>Scheduling &amp; Special Requirements</b>	Groups of visits spaced apart every ~6 weeks SAA free
<b>Changes from Cycle 29</b>	48 internal visits (instead of 54) due to phase wrt cycle boundaries

# STIS NUV MAMA Dark Monitor

## PI: Amy M Jones

<b>Purpose</b>	Monitor the behavior of the dark current in the NUV-MAMA detector, provide data for dark count corrections for faint object observations, and also provide a check on the health of the detector
<b>Description</b>	Every two weeks a set of two 1300 s exposures is taken with the NUV-MAMA with the shutter closed. The exposures are taken separated by six hours within an SAA-free period. This separates long and short term temporal effects.
<b>Fraction GO/GTO Programs Supported</b>	35.8% of total STIS exposure time (cycle 29)
<b>Resources Required: Observations</b>	52 internal orbits
<b>Resources Required: Analysis</b>	2 FTE weeks
<b>Products</b>	Dark reference files and tables modeling time and temperature dependence of dark rates. Update to monitoring webpage.
<b>Accuracy Goals</b>	1%
<b>Scheduling &amp; Special Requirements</b>	Pairs of visits spaced apart every 2 weeks SAA free
<b>Changes from Cycle 29</b>	No changes

# STIS FUV-MAMA Flat-Field Monitor

PI: Amy M Jones

<b>Purpose</b>	The goal of this program is to obtain FUV-MAMA flat-field observations to create a new p-flat with a SNR of $\sim 100$ per low-res pixel. The flats are obtained with the Krypton lamp and the medium-resolution G140M grating (as in the cycle 28 program). The exact instrument setup (slit width and central wavelength) might change, however, depending on the achieved count level (which may be close to the allowed global rate limit).
<b>Description</b>	Past experience and observations have shown that 11 visits are sufficient to build a p-flat with the required SNR $\sim 100$ per low-res pixel. The G140M flats will be taken with the slit at 5 different offset positions in order to illuminate the detector regions which are normally shadowed by the slit bars. The exact instrument setup (slit width and central wavelength) may change during the cycle depending on the desired count level of each exposure.
<b>Fraction GO/GTO Programs Supported</b>	46.4% of STIS total exposure time (Cycle 29)
<b>Resources Required: Observations</b>	11 internal orbits (all orbits $> 1800$ s)
<b>Resources Required: Analysis</b>	4 FTE weeks
<b>Products</b>	This cycle p-flat is primarily for monitoring purpose. The achievable SNR is limited by the Poisson noise. If applicable, a new reference p-flat will be created combining FUV flats from several cycles.
<b>Accuracy Goals</b>	1.0% accuracy in per low-res pixel (i.e., $2 \times 2$ high-res pixels)
<b>Scheduling &amp; Special Requirements</b>	FUV- and NUV-MAMA flat observations are executed on alternate cycles to save lamp lifetimes. Visits are spaced by $\sim 1$ month through the cycle.
<b>Changes from Cycle 29</b>	This cycle is for the FUV-MAMA flats, while Cycle 29 was for the NUV-MAMA flats.

# Monitoring the 3 Primary White Dwarf Standard Stars

PI: Ralph Bohlin

<b>Purpose</b>	Repeated observations of the 3 primary WD standards (G191B2B, GD153, GD71) can reveal any variability in any one of the 3, as well as in our MAMA and CCD monitor standards (GRW+70 2824, AGK+81 266). STIS should observe the primary WD triad with a cadence of every alternate year. Rather than putting 'all our eggs in one basket' and depending only on single sensitivity monitoring stars, prudence suggests that return visits in low dispersion by STIS to the fundamental triad should be executed at something approaching the historic cadence. In addition to variability checks, each new observation adds to the statistical precision of the STIS flux calibration that is defined by these 3 stars.
<b>Description</b>	Observations are in the 5 low dispersion modes G140L, G230L, G230LB, G430L, and G750L with the 52x2 slit. For efficiency, the STIS MAMA and CCD observations will be combined in the same visit; and the wavecalcs and fringe flats will be pushed to the end-of-orbit occultation, as possible. The MAMA observations may violate a current bright-object limit but have been grandfathered in, because the many past observations have not caused a problem.
<b>Fraction GO/GTO Programs Supported</b>	92.0% of STIS total exposure time (cycle 29)
<b>Resources Required: Observations</b>	5 external orbits
<b>Resources Required: Analysis</b>	0.1 FTE
<b>Products</b>	The standard data analysis produces figures that illustrate the average change in response for the 5 STIS low dispersion modes in comparison to the triad of primary standards. The uncertainty in the STIS TDS correction is determined by the level of agreement between the triad of WDs and the respective monitoring standards. Updated absolute flux calibration.
<b>Accuracy Goals</b>	<1%
<b>Scheduling &amp; Special Requirements</b>	disable monthly MAMA offsets
<b>Changes from Cycle 29</b>	Same as Cycles 24, 26, and 28 (performed every other year).

# STIS MAMA Fold Distribution

## PI: Thomas Wheeler

<b>Purpose</b>	The fold analysis provides a measurement of the distribution of charge cloud sizes incident upon the anode providing some measure of changes in the pulse-height distribution of the MCP and, therefore, MCP gain.
<b>Description</b>	While globally illuminating the detector with a flat field, the valid event (VE) rate counter is monitored, while various combinations of row and column folds are selected.
<b>Fraction GO/GTO Programs Supported</b>	82.2% of STIS total exposure time (cycle 29)
<b>Resources Required: Observations</b>	2 internal orbits
<b>Resources Required: Analysis</b>	0.5 FTE day.
<b>Products</b>	The results will be sent to the STIS Team and Steve Franka of Ball Aerospace.
<b>Accuracy Goals</b>	5% for peak of fold distribution
<b>Scheduling &amp; Special Requirements</b>	This proposal is executed annually (usually in spring). Special commanding is required.
<b>Changes from Cycle 29</b>	No changes

# **Contingency Programs**

# STIS MAMA Recovery from Anomalous Shutdown

## PI: Thomas Wheeler

<b>Purpose</b>	Safe and orderly recovery of either MAMA detector from an anomalous shutdown.
<b>Description</b>	The recovery procedure consists of three separate tests (i.e. visits) to check the MAMA's health after an anomalous shutdown. Each must be successfully completed before proceeding onto the next. They are: (1) signal processing electronics check, (2) slow, intermediate voltage high-voltage ramp-up, and (3) ramp-up to full operating voltage.
<b>Fraction GO/GTO Programs Supported</b>	82.2% of STIS total exposure time (cycle 29)
<b>Resources Required: Observations</b>	8 internal orbits
<b>Resources Required: Analysis</b>	If activated, 0.5 FTE day per test.
<b>Products</b>	For tests 1-3, only a Go/No-Go to proceed will be given.
<b>Accuracy Goals</b>	N/A
<b>Scheduling &amp; Special Requirements</b>	This is a contingency proposal activated only in the event of an anomalous shutdown. This proposal is usually followed by the STIS MAMA Fold Distribution proposal. Special commanding is required.
<b>Changes from Cycle 29</b>	No changes

# **Cycle 29 Usage Statistics**

# STIS Cycle 29 Usage Statistics for each Configuration/Mode

Configuration/Mode	Percentage of STIS Prime Exposure Time		Percentage of STIS SNAP Exposure Time		Percentage of STIS Total Exposure Time	
	C28	C29	C28	C29	C28	C29
<b>CCD</b>	<b>19.0%</b>	<b>16.0%</b>	<b>47.5%</b>	<b>100.0%</b>	<b>21.6%</b>	<b>17.8%</b>
CCD/Imaging	5.6%	2.9%	0.0%	0.0%	5.1%	2.9%
CCD/Spectroscopy	13.4%	13.1%	47.5%	100.0%	16.5%	14.9%
<b>MAMA/FUV</b>	<b>43.5%</b>	<b>47.4%</b>	<b>0.0%</b>	<b>0.0%</b>	<b>39.6%</b>	<b>46.4%</b>
FUV/Imaging	4.7%	2.6%	0.0%	0.0%	4.3%	2.5%
FUV/Spectroscopy	38.8%	44.8%	0.0%	0.0%	35.3%	43.9%
<b>MAMA/NUV</b>	<b>37.5%</b>	<b>36.6%</b>	<b>52.5%</b>	<b>0.0%</b>	<b>38.8%</b>	<b>35.8%</b>
NUV/Imaging	0.0%	2.7%	0.0%	0.0%	0.0%	2.6%
NUV/Spectroscopy	37.5%	33.9%	0.0%	0.0%	38.8%	33.2%

# STIS Cycle 29 Usage Statistics for each Grating/Mirror Combination

Configuration/Mode	Grating/Mirror	Percentage of STIS Prime Science Exposure Time		Percentage of STIS SNAP Science Exposure Time		Percentage of STIS Total Science Exposure Time	
		C28	C29	C28	C29	C28	C29
STIS/CCD	G230LB	3.8%	3.6%	20.6%	100.0%	5.3%	5.6%
(17.8%)	G230MB	0.0%	0.0%	0.0%	0.0%	0.0%	0.0%
	G430L	3.9%	6.4%	26.9%	0.0%	6.0%	6.3%
	G430M	1.4%	0.0%	--	0.0%	1.2%	0.0%
	G750L	3.5%	1.9%	--	0.0%	3.1%	1.9%
	G750M	0.9%	1.2%	--	0.0%	0.8%	1.2%
	MIRROR/CORON	5.6%	2.9%	--	0.0%	5.1%	2.9%
STIS/MAMA-FUV	E140H	3.9%	2.8%	--	0.0%	3.5%	2.7%
(46.4%)	E140M	6.7%	2.3%	--	0.0%	6.1%	2.3%
	G140L	16.5%	27.3%	--	0.0%	15.0%	26.7%
	G140M	11.8%	12.5%	--	0.0%	10.7%	12.2%
	MIRROR	4.7%	2.6%	--	0.0%	4.3%	2.5%
STIS/MAMA-NUV	E230H	5.4%	4.0%	52.5%	0.0%	9.6%	3.9%
(35.8%)	E230M	4.5%	3.8%	--	0.0%	4.1%	3.7%
	G230L	27.6%	26.1%	--	0.0%	25.1%	25.5%
	G230M	--	0.0%	--	0.0%	--	0.0%
	MIRROR	--	2.7%	--	0.0%	--	2.6%

# Cycle 29 Instrument Usage Statistics Based on Approved Programs

STIS orbits comprised ~**26.6%** of all GO prime orbits  
(regular programs only) in Cycle 29

Instruments	Prime Orbits Usage Regular	SNAP Orbit Usage Regular
ACS	11.1%	23%
COS	30.7%	10%
STIS	26.6%	2%
WFC3	31.6%	65%
FGS	0.0%	--

[Taken from presentation (10/08/2021) by C. Leitherer on Cycle 29 regular  
program results, based on 2695 total orbits approved.]